Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/603,361	CHAN ET AL.	
Examiner	Art Unit	
Ron E. Pompey	2812	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Used the same refereces as in previous action mailed, 1-13-05	12/26/2005	RP		